

DATA SHEET

SURFACE MOUNT MULTILAYER CERAMIC CAPACITORS

Automotive grade NPO/X7R 6.3 V TO 630 V

 $\,$ 0.47 pF to $\,$ 2.2 μF RoHS compliant & Halogen Free



YAGEO Phícomp



SCOPE

This specification describes Automotive grade NP0/X7R series chip capacitors with lead-free terminations and used for automotive equipments.

<u>APPLICATIONS</u>

All general purpose applications Entertainment applications Comfort / security applications Information applications

FEATURES

- · AEC-Q200 qualified
- MSL class: MSL I
- AC series soldering is compliant with J-STD-020D
- Halogen free epoxy
- RoHS compliant
- · Reduce environmentally hazardous waste
- · High component and equipment reliability
- Save PCB space
- The capacitors are 100% performed by automatic optical inspection prior to taping.

ORDERING INFORMATION - GLOBAL PART NUMBER

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

GLOBAL PART NUMBER

AC XXXX X X XXX X B X XXX

(6) (7) (1) (2) (3) (4) (5)

(I) SIZE – INCH BASED (METRIC)

0201 (0603) / 0402 (1005) / 0603 (1608) / 0805 (2012) / 1206 (3216)/ 1210 (3225) / 0508 (1220) / 0612 (1632)

(2) TOLERANCE

 $B = \pm 0.1 pF$

 $C = \pm 0.25 \text{ pF}$

 $D = \pm 0.5 pF$

 $F = \pm 1\%$

 $G = \pm 2\%$

 $| = \pm 5\%$

 $K = \pm 10\%$

 $M = \pm 20\%$

(3) PACKING STYLE

R = Paper/PE taping reel; Reel 7 inch

K = Blister taping reel; Reel 7 inch

P = Paper/PE taping reel; Reel 13 inch

F = Blister taping reel; Reel 13 inch

(4) TC MATERIAL

NPO

X7R

(5) RATED VOLTAGE

5 = 6.3 V

6 = 10 V

7 = 16 V

8 = 25 V

9 = 50 V

0 = 100 V

A = 200 V

Y = 250 V

B = 500 V

Z = 630 V

(6) PROCESS

N=NP0

B = Class 2 MLCC

(7) CAPACITANCE VALUE

2 significant digits+number of zeros

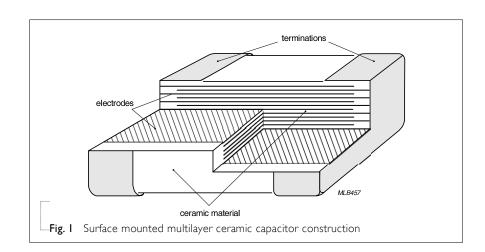
The 3rd digit signifies the multiplying factor, and letter R is decimal point

Example: $121 = 12 \times 10^{1} = 120 \text{ pF}$

CONSTRUCTION

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (Matte Sn). The terminations are leadfree. A cross section of the structure is shown in Fig.1.



DIMENSION

Table I For outlines see fig. 2

		0				
TYPE	L _I (mm)	W (mm)	T (MM)	L ₂ / I	L ₃ (mm) max.	L ₄ (mm) min.
0201	0.6 ±0.03	0.3 ±0.03		0.10	0.20	0.20
0402	1.0 ±0.05	0.5 ±0.05		0.15	0.30	0.40
0603	1.6 ±0.10	0.8 ±0.10		0.20	0.60	0.40
0805	2.0 ±0.20	1.25 ±0.20	Refer to table 3 to 12	0.25	0.75	0.70
1206	3.2 ±0.30	1.6 ±0.20		0.25	0.75	1.40
1210	3.2 ±0.30	2.5 ±0.20		0.25	0.75	1.40
1812	4.5±0.40	3.2±0.40		0.25	0.75	2.20

OUTLINES

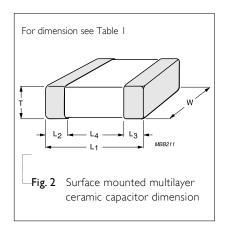
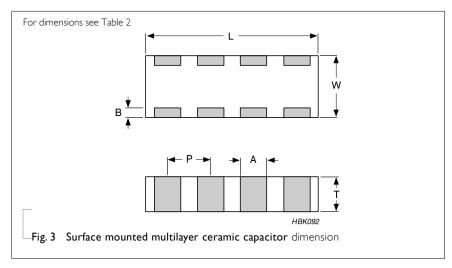


Table 2 For outlines see fig. 3

TYPE	0508 (4 X 0402)	0612 (4 X 0603)
L (mm)	2.0 ±0.15	3.2 ±0.15
W (mm)	1.25 ±0.15	1.60 ±0.15
$T_{min.}$ (mm)	0.50	0.70
$T_{max.}$ (mm)	0.70	0.90
A (mm)	0.28 ±0.10	0.4 ±0.10
B (mm)	0.2 ±0.10	0.3 ±0.20
P (mm)	0.5 ±0.10	0.8 ±0.10

OUTLINES



CAPACITANCE RANGE & THICKNESS FOR NPO

Table 3	Sizes from 0402 to						
CAP.	0402 50 ∨	0603 50 V	100 V	250 V	0805 50 V	100 V	250V
0.47 pF							
0.47 pF 0.56 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
0.68 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
0.82 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
1.0 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
1.2 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
1.5 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
1.8 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
2.2 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
2.7 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
3.3 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
3.9 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
4.7 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
5.6 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
6.8 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
8.2 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
10 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
12 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
15 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
18 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
22 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
27 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
33 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
39 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
47 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
56 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
68 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
82 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
100 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1

NOTE

CAPACITANCE RANGE & THICKNESS FOR NPO

Table 4	Sizes from 0402 to 0)805 (continued)					
CAP.	0402	0603			0805		
	50 V	50 V	100 V	250 V	50 V	100 V	250 V
120 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
150 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
180 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.6±0.1
220 pF	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.85±0.1
270 pF		0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.85±0.1
330 pF		0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.85±0.1
390 pF		0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.85±0.1
470 pF		0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.6±0.1	0.85±0.1
560 pF		0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.85±0.1	0.85±0.1
680 pF		0.8±0.1	0.8±0.1	0.8±0.1	0.6±0.1	0.85±0.1	0.85±0.1
820 pF					0.6±0.1	0.85±0.1	0.85±0.1
1.0 nF		0.8±0.1			0.6±0.1	0.85±0.1	0.85±0.1
I.2 nF							
1.5 nF							
I.8 nF							
2.2 nF							
2.7 nF							
3.3 nF							
3.9 nF							
4.7 nF							
5.6 nF							
6.8 nF							
8.2 nF							
I0 nF							

NOTE

CAPACITANCE RANGE & THICKNESS FOR NPO

Table 5	Sizes from 120	06 to 1210							
CAP.	1206					1210			
	50 V	100 V	250 V	500 V	630 V	50 V	100 V	250 V	500 V
10 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2	-	-	-	
12 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
15 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
18 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
22 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
27 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
33 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
39 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
47 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
56 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
68 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
82 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
100 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
120 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
150 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
180 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
220 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
270 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
330 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
390 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
470 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
560 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
680 pF	0.6±0.1	0.6±0.1	0.6±0.1	0.6±0.1	1.25±0.2				
820 pF	0.6±0.1	0.6±0.1	0.85±0.1	0.85±0.1	1.25±0.2				
I.0 nF	0.6±0.1	0.6±0.1	0.85±0.1	0.85±0.1	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2
1.2 nF	0.6±0.1	0.6±0.1	0.85±0.1			1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2
1.5 nF	0.6±0.1	0.6±0.1	0.85±0.1			1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2
1.8 nF	0.6±0.1	0.6±0.1				1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2
2.2 nF	0.6±0.1	0.6±0.1				1.25±0.2	1.25±0.2	1.25±0.2	
2.7 nF	0.6±0.1	0.6±0.1				1.25±0.2	1.25±0.2	1.25±0.2	
3.3 nF									
3.9 nF									
4.7 nF									
5.6 nF									
6.8 nF									
8.2 nF									
10 nF									

NOTE



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CAPACITANCE RANGE & THICKNESS FOR X7R

Table 6	Sizes from 04	402 to 0603								
CAP.	0201	0402		25.4	-0.14	0603		 .	=0.1	
	25V	10V	16 V	25 V	50 V	10V	16 V	25 V	50 V	100 V
100 pl	F 0.3±0.03									
150 pl	F 0.3±0.03									
220 pl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05					
330 pl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05					
470 pl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05					
680 pl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05					
1.0 nl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
1.5 nl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
2.2 nl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
3.3 nl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
4.7 nl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
6.8 nl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
10 nl	F 0.3±0.03	0.5±0.05	0.5±0.05	0.5±0.05	0.5±0.05	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
15 nl	F	0.5±0.05	0.5±0.05	0.5±0.05		0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
22 nl	F	0.5±0.05	0.5±0.05	0.5±0.05		0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
33 nl	F	0.5±0.05	0.5±0.05	0.5±0.05		0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
47 nl	F	0.5±0.05	0.5±0.05	0.5±0.05		0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1
68 nl	F	0.5±0.05	0.5±0.05			0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	
100 nl	F	0.5±0.05	0.5±0.05			0.8±0.1	0.8±0.1	0.8±0.1	0.8±0.1	
150 nl	F					0.8±0.1	0.8±0.1			
220 nl	F					0.8±0.1	0.8±0.1	0.8±0.1		
330 nl	F					0.8±0.1	0.8±0.1			
470 nl	F					0.8±0.1	0.8±0.1			
680 nl	F									
lμl	F					0.8±0.1				

NOTE

CAPACITANCE RANGE & THICKNESS FOR X7R

Table 8 Size 0805 0805 CAP.

CAP.	0805						
	10 V	16 V	25 V	50 V	100 V	250 V	500 V
100 pF	·	-	·	·	•	-	
150 pF							
220 pF							
330 pF							
470 pF							
680 pF							
1.0 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1
1.5 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1
2.2 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1
3.3 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1
4.7 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1
6.8 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2	
10 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2	
15 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2	
22 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2	
33 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2		
47 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2		
68 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1 1.25±0.2	1.25±0.2		
100 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1 1.25±0.2	1.25±0.2		
150 nF	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2			
220 nF	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2			
330 nF	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2			
470 nF	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2			
680 nF	1.25±0.2	1.25±0.2	1.25±0.2				
ΙμF	1.25±0.2	1.25±0.2	1.25±0.2				
2.2 µF	1.25±0.2						

NOTE



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Surface-Mount Ceramic Multilayer Capacitors | Automotive grade | NP0/X7R | 6.3 V to 630 V

CAPACITANCE RANGE & THICKNESS FOR X7R

Table 9 Size	Table 9 Size 1206									
CAP.	1206									
	6.3 V	10V	16V	25V	50 V	100 V	250 V			
22 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2			
33 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1				
47 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1				
68 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2				
100 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2				
150 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2	1.25±0.2				
220 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2	1.25±0.2				
330 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.6±0.2					
470 nF	1.00±0.1	1.00±0.1	1.00±0.1	1.00±0.1	1.6±0.2					
680 nF	1.15±0.1	1.15±0.1	1.15±0.1	1.6±0.2						
ΙμF	1.15±0.1	1.15±0.1	1.15±0.1	1.6±0.2						
2.2 uF										
4.7 uF										
IO uF	1.6±0.2									

NOTE



CAPACITANCE RANGE & THICKNESS FOR X7R

Ī	Table 10	Size 1210								
(CAP.	1210 6.3V	10 V	16 V	25 V	50V	100 V	250 V	1812 50V	100V
Ī	100 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.25±0.2		
	150 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.15±0.1	1.25±0.2			
	220 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.15±0.1	1.25±0.2			
	330 nF	0.85±0.1	0.85±0.1	0.85±0.1	0.85±0.1	1.15±0.1				
	470 nF	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2			1.60±0.2	1.60±0.2
	680 nF	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2			1.60±0.2	1.60±0.2
	ΙμF	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2	1.25±0.2			1.60±0.2	1.60±0.2

NOTE

CAPACITANCE RANGE & THICKNESS FOR 4C-ARRAY

Table II Temperature characteristic material from NP0

Table 11 Temperature cha	0508 (4 x 0402)	0612 (4 × 0603)
CAPACITANCE	50 V	50 V
10 pF	0.6±0.1	0.8±0.1
15 pF	0.6±0.1	0.8±0.1
18 pF	0.6±0.1	0.8±0.1
22 pF	0.6±0.1	0.8±0.1
33 pF	0.6±0.1	0.8±0.1
39 pF	0.6±0.1	0.8±0.1
47 pF	0.6±0.1	0.8±0.1
56 pF	0.6±0.1	0.8±0.1
68 pF	0.6±0.1	0.8±0.1
82 pF	0.6±0.1	0.8±0.1
100 pF	0.6±0.1	0.8±0.1
120 pF		0.8±0.1
150 pF		0.8±0.1
180 pF		0.8±0.1
220 pF		0.8±0.1
270 pF		0.8±0.1
330 pF		0.8±0.1
390 pF		0.8±0.1
470 pF		0.8±0.1
560 pF		
680 pF		
820 pF		
I.O nF		

NOTE

CAPACITANCE RANGE & THICKNESS FOR 4C-ARRAY

Table 12 Temperature characteristic material from X7R

CAPACITANCE	$0508 (4 \times 0402)$			0612 (4 × 0603)		
	16 V	25 V	50 V	16 V	25 V	50 V
220 pF	-			0.8±0.1	0.8±0.1	0.8±0.1
330 pF				0.8±0.1	0.8±0.1	0.8±0.1
470 pF				0.8±0.1	0.8±0.1	0.8±0.1
680 pF				0.8±0.1	0.8±0.1	0.8±0.1
I,0 nF	0.6±0.1	0.6±0.1	0.6±0.1	0.8±0.1	0.8±0.1	0.8±0.1
1,5 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1
2.2 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1
3.3 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1
4.7 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1
6.8 nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1
IO nF	0.6±0.1	0.6±0.1		0.8±0.1	0.8±0.1	0.8±0.1
15 nF	0.6±0.1			0.8±0.1	0.8±0.1	
22 nF	0.6±0.1			0.8±0.1	0.8±0.1	
33 nF	0.6±0.1			0.8±0.1	0.8±0.1	
47 nF	0.6±0.1			0.8±0.1	0.8±0.1	
68 nF	0.6±0.1					
100 nF	0.6±0.1					

NOTE

THICKNESS CLASSES AND PACKING QUANTITY

-	-			
	a	h	le l	1.3

Table 15			Ø100 M	4 / 7 INICLI	Ø220 MM	/ 12 15 16 1
SIZE CODE	THICKNESS CLASSIFICATION	TAPE WIDTH — QUANTITY PER REEL	Paper	1 / 7 INCH Blister	Paper	/ 13 INCH Blister
0201	0.3 ±0.03 mm	8 mm	15,000		50,000	
0402	0.5 ±0.05 mm	8 mm	10,000		50,000	
0603	0.8 ±0.1 mm	8 mm	4,000		15,000	
	0.6 ±0.1 mm	8 mm	4,000		20,000	
0805/0508	0.85 ±0.1 mm	8 mm	4,000		15,000	
	1.25 ±0.2 mm	8 mm		3,000		10,000
	0.6 ±0.1 mm	8 mm	4,000		20,000	
	0.85 ±0.1 mm	8 mm	4,000		15,000	
1206/0612	1.0/1.15 ±0.1 mm	8 mm		3,000		10,000
	1.25 ±0.2 mm	8 mm		3,000		10,000
	1.6 ±0.2 mm	8 mm		2,000		10,000
	0.85 ±0.1 mm	8 mm		4,000		10,000
1210	1.15 ±0.1 mm	8 mm		3,000		10,000
	1.25 ±0.2 mm	8 mm		3,000		10,000
	0.6 / 0.85±0.1 mm	I2 mm		2,000		
1812	1.15±0.1 mm	I2 mm		1,000		
	1.25±0.2 mm	I2 mm		1,000		



NP0/X7R 6.3 V to 630 V

ELECTRICAL CHARACTERISTICS

NP0/X7R DIELECTRIC CAPACITORS; NI/SIN TERMINATIONS

Unless otherwise specified, all test and measurements shall be made under standard atmospheric conditions for testing as given in 5.3 of IEC 60068-1:

- Temperature: 15 °C to 35 °C - Relative humidity: 25% to 75% - Air pressure: 86 kPa to 106 kPa

Before the measurements are made, the capacitor shall be stored at the measuring temperature for a time sufficient to allow the entire capacitor to reach this temperature.

The period as prescribed for recovery at the end of a test is normally sufficient for this purpose.

	Table 14									
	CRIPTION									VALUE
	citance range								0.47 pF	to I µF
•	citance tolera									
NP(· · · ·								±0.25 pF,	±0.5 pF
	C ≥ 10 F	oF .							±2	2%, ±5%
X7F	R								±5% ⁽¹⁾ , ±10%	%, ±20%
Dissi	pation factor (D.F.)								
NP	0	C < 30 pF							≤ 1 / (400	+ 20C)
		$C \ge 30 pF$								≤ 0.1 %
X7R	020	I 0402	0603	0805	1206	1210	1812	0508 (Array)	0612 (Array)	
≤I0V	2	20pF to 100nF	InF to IuF	InF to 2.2uF	22nF to TuF	100nF to 1uF				≤ 5%
					10uF					≤ 10%
16V		220pF to 22nF	InF to 220nF	InF to 470nF	22nF to TuF	100nF to 1uF		InF to IOnF	220pF to 47nF	≤ 3.5%
		27nF to 100nF	470nF	680nF to TuF				5nF to 100nF		≤ 5%
25V	100pF to 470pF	220pF to 10nF	InF to 39nF	InFto 180nF	22nF to 680nF	100nF to 1uF		InFto IOnF	220pF to 47nF	≤ 2.5%
		12nF to 47nF	47nF to 220nF	220nF to 470nF	IuF					≤ 3.5%
	560pF to 10nF			680nF to TuF						≤ 5%
50V		220pF to 10nF	InF to 39nF	InFto 180nF	22nF to 470nF	100nF to 1uF	470nF to TuF	InF	220pF to 10nF	≤ 2.5%
			47nF to 100nF	220nF to 470nF						≤ 3.5%
100V			InF to I0nF	InF to 100nF	22nF to 220nF	100nF to 220nF	470nF to TuF			≤ 2.5%
			12nF to 47nF			470nF				≤ 5%
250V				InF to 22nF		100nF				≤ 2.5%
500V				InF to 4.7nF						≤ 2.5%
Insula	ation resistanc	e after I mi	nute at U _r (D	C)			Ω or I,R × C≥ 100 Ω ,F: X7F		ds whichever is 76.3V	s less
(tem	perature chara	_		f temperature						
NP(-								±30	ppm/°C
X7F	K									±15%
-	rating tempera 0/X7R	ture range:							–55 °C to ∃	-125°C
									-33 C 10	125 C

NOTE

^{1.} Capacitance tolerance ±5% doesn't available for X7R full product range, please contact local sales force before order

SOLDERING RECOMMENDATION

 Tab	le	۱5

SOLDERING METHOD	SIZE 0402	0603	0805	1206	≥ 1210
Reflow	≥ 0.1 µF	≥ 1.0 µF	≥ 2.2 µF	≥ 4.7 µF	Reflow only
Reflow/Wave	< 0.1 µF	< 1.0 µF	< 2.2 µF	< 4.7 µF	

SOLDERING CONDITIONS

The lead free MLCCs are able to stand the reflow soldering conditions as below:

- Temperature: above 220 °C
- Endurance: 95 to 120 seconds
- Cycles: 3 times

The test of "soldering heat resistance" is carried out in accordance with the schedule of "MIL-STD-202F-method 210F", "The robust construction of chip capacitors allows them to be completely immersed in a solder bath of 270 °C for 10 seconds". Therefore, it is possible to mount MLCCs on one side of a PCB and other discrete components on the reverse (mixed PCBs). Surface Mount Capacitors are tested for solderability at 245 °C during 2 seconds. The test condition for no leaching is 260°C for 30 seconds.

TESTS AND REQUIREMENTS

Table 16 Test procedures and requirements

TEST	TEST METHOD		PROCEDURE	REQUIREMENTS	
Mounting	IEC 60384- 21/22	4.3	The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage	
Capacitance	IEC 60384- 21/22	4.5.1	Class I: At 20 °C, 24 hours after annealing $f = 1$ MHz for $C \le 1$ nF, measuring at voltage 1 V_{rms} at 20 °C 1 InF , measuring at voltage 1 V_{rms} at 20 °C Class 2: At 20 °C, 24 hours after annealing 1 V_{rms} at 20 °C	Within specified tolerance	
Dissipation Factor (D.F.)	IEC 60384- 21/22	4.5.2	Class I: At 20 °C, 24 hours after annealing $f = 1 \text{ MHz for C} \leq \text{InF, measuring at voltage I V}_{rms} \text{ at } 20 °C$ $f = 1 \text{ KHz for C} > \text{InF, measuring at voltage I V}_{rms} \text{ at } 20 °C$ $Class 2:$ At 20 °C, 24 hours after annealing $f = 1 \text{ KHz, measuring at voltage I V}_{rms} \text{ at } 20 °C$	In accordance with specification	
Insulation Resistance	IEC 60384- 21/22	4.5.3	At U _r (DC) for I minute	In accordance with specification	



TEST

Temperature

coefficient

TEST METHOD

PROCEDURE

following table.

Capacitance shall be measured by the steps shown in the

The capacitance change should be measured after 5 min at each specified temperature stage.

Step	Temperature(°C)
a	25±2
Ь	Lower temperature±3°C
С	25±2
d	Upper Temperature±2°C
е	25±2

(I) Class I

Temperature Coefficient shall be calculated from the formula as below

Temp, Coefficient =
$$\frac{C2 - C1}{C1 \times \Delta T} \times 10^6 \text{ [ppm/°C]}$$

C1: Capacitance at step c

C2: Capacitance at 125°C

$$\Delta$$
T: 100°C(=125°C-25°C)

(2) Class II

Capacitance Change shall be calculated from the formula as

$$\Delta C = \frac{C2 - C1}{C1} \times 100\%$$

C1: Capacitance at step c

C2: Capacitance at step b or d

REQUIREMENTS

<General purpose series>

Class I:

 Δ C/C: \pm 30ppm

Class2:

X7R: Δ C/C: $\pm 15\%$

<High Capacitance series>

X7R/X5R: Δ C/C: \pm 15%

High Temperature Exposure

AEC-Q200

3

Unpowered; 1000hours@T=150°C

Measurement at 24±2 hours after test conclusion.

No visual damage

 Δ C/C :

Class I:

NP0: within $\pm 0.5\%$ or 0.5~pFwhichever is greater

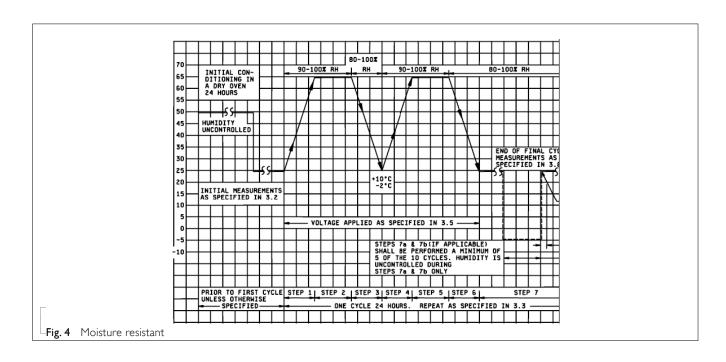
Class2: X7R: ±10%

D.F.:

within initial specified value

within initial specified value

TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS
Temperature Cycling	AEC-Q200	4	Preconditioning; I50 +0/–I0°C for I hour, then keep for	No visual damage
			24 ±1 hours at room temperature 1000 cycles with following detail: 30 minutes at lower category temperature 30 minutes at upper category temperature	ΔC/C Class I: NP0: Within ±1% or 0.5pF, whichever is greater. Class 2:
			Recovery time 24 ±2 hours	X7R: ±10% D.F. meet initial specified value
				IR meet initial specified value
Destructive Physical Analysis	AEC-Q200	5	I Oea X 3 lots. Note: Only applies to SMD ceramics. Electrical test not required.	
Moisture Resistance	AEC-Q200	6	T=24 hrs/per cycle; 10 continuous cycles unpowered. Measurement at 24 ±2 hours after test condition.	No visual damage
				ΔC/C NP0: Within ±3% or 3 pF, whichever is greater X7R: ±15%
				D.F. Within initial specified value IR NP0: \geq 10,000 M Ω X7R: Meet initial specified value

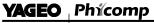


Surface-Mount Ceramic Multilayer Capacitors | Automotive grade | NP0/X7R | 6.3 V to 630 V

TEST	TEST METHO	DD	PROCEDURE	REQUIREMENTS
Biased Humidity	AEC-Q200	7	 Preconditioning, class 2 only: 150 +0/-10 °C /1 hour, then keep for 24 ±1 hour at room temp 	No visual damage after recovery
			 Initial measure: Parameter: IR Measuring voltage: 1.5V ± 0.1 VDC Note: Series with 100 KΩ & 6.8 KΩ Test condition: 85 °C, 85% R.H. connected with 100 KΩ resistor, applied 1.5V/U_r for 1,000 hours. Recovery: Class 1: 6 to 24 hours Class2: 24 ±2 hours Final measure: IR 	Initial requirement: Class I: - Connected to $100 \text{ K}\Omega$: $C \le 10 \text{ nF}$: $I.R \ge 10,000 \text{ M}\Omega$ or $C > 10 \text{ nF}$: $(I.R-100 \text{ K}\Omega) \times C$ $\ge 100s$. - Connected to $6.8 \text{ K}\Omega$: $C \le 10 \text{ nF}$: $I.R \ge 10,000 \text{ M}\Omega$ or $C > 10 \text{ nF}$: $(I.R-6.8 \text{ K}\Omega) \times C$ $\ge 100s$. Class 2: - Connected to $100 \text{ K}\Omega$: $C \le 25 \text{ nF}$: $I.R \ge 4,000 \text{ M}\Omega$ or $C > 25 \text{ nF}$: $(I.R-100 \text{ K}\Omega) \times C$ $\ge 100s$. - Connected to $6.8 \text{ K}\Omega$: $C \le 25 \text{ nF}$: $I.R \ge 10,000 \text{ M}\Omega$ or $C > 25 \text{ nF}$: $I.R \ge 10,000 \text{ M}\Omega$ or $C > 25 \text{ nF}$: $I.R \ge 10,000 \text{ M}\Omega$ or $C > 25 \text{ nF}$: $I.R \ge 10,000 \text{ M}\Omega$ or $C > 100 \text{ m}$. Final measurement: The insulation resistance shall be greater than 0.1 time initial value.

TEST	TEST METH	HOD	PROCEDURE	REQUIREMENTS	
Operational Life	AEC-Q200	8	1. Preconditioning, class 2 only: 150 +0/-10 °C /1 hour, then keep for	No visual damage	
			24 ±1 hour at room temp	ΔC/C	
			2. Initial measure:	NP0: Within $\pm 2\%$ or I pF,	
			Spec: refer to initial spec C, D, IR	whichever is greater	
			3. Endurance test:	X7R: ±15%	
			Temperature: X7R: 125 °C	D.F.	
			Specified stress voltage applied for 1,000 hours:	NP0: $\leq 2 \times \text{specified value}$.	
			Applied $2.0 \times U_r$ for general products	$X7R: \le 16V: \le 7\%$ or specified	
			Applied 1.5 \times U _r for high cap. Products	value whichever is greater	
			High voltage series follows with below	≥ 25V: ≤ 5% or specified	
			stress condition:	value whichever is greater	
			Applied 1.5 \times Ur for 200V, 250V series		
			Applied 1.3 \times Ur for 500V, 630V series	IR	
			Applied 1.2 \times Ur for 1 KV, 2 KV, 3 KV series	NP0: \geq 4,000 M Ω or IR \times C _r \geq	
			4. Recovery time: 24 ±2 hours	40s whichever is less	
			5. Final measure: C, D, IR	X7R: \geq 1,000 M Ω or IR× C _r \geq 50s whichever is less	
			Note: If the capacitance value is less than the minimum value permitted, then after the other measurements have been made the capacitor shall be preconditioned according to "IEC 60384 4.1" and then the requirement shall be met.		
External Visual	AEC-Q200	9	Any applicable method using × 10 magnification	In accordance with specification	
Physical Dimension	AEC-Q200	10	Verify physical dimensions to the applicable device specification.	In accordance with specification	
Mechanical Shock	AEC-Q200	AEC-Q200 13	a a a a a. a.	Duration: 0.5 ms	Δ C/C NP0: Within ±0.5% or 0.5 pF, whichever is greater X7R: ±10%
			Velocity change: 15.4 ft/s	D.F.	
			Waveform: Half-sin		
				Within initial specified value	
				IR	
				Within initial specified value	
Vibration	AEC-Q200	14	5 g's for 20 minutes, 12 cycles each of 3 orientations. Note: Use $8'' \times 5''$ PCB. $0.31''$ thick 7 secure points on one long side and 2 secure points at corners of opposite sides. Parts	Δ C/C NP0: Within ±0.5% or 0.5 pF, whichever is greater X7R: ±10%	
			mounted within 2" from any secure point. Test from		
			10-2000 Hz.	D.F: meet initial specified value IR meet initial specified value	

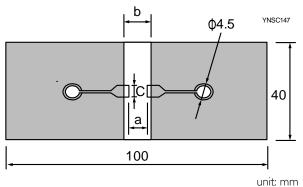
TEST	TEST METHOD		PROCEDURE	REQUIREMENTS		
Resistance to Soldering Heat	AEC-Q200	C-Q200 15	Precondition: $150 \pm 0/-10$ °C for I hour, then keep for 24 ± 1 hours at room temperature Preheating: for size ≤ 1206 : 120 °C to 150 °C for I minute Preheating: for size ≥ 1206 : 100 °C to 120 °C for I minute	Dissolution of the end face plating shall not exceed 25% of the length of the edge concerned		
			and 170 °C to 200 °C for I minute Solder bath temperature: 260 ±5 °C Dipping time: 10 ±0.5 seconds Recovery time: 24 ±2 hours	Δ C/C Class I: NP0: Within ±1% or 0.5 pF, whichever is greater. Class2: X7R: ±10%		
				D.F. within initial specified value		
				IR within initial specified value		
Thermal Shock	AEC-Q200	16	1. Preconditioning, class 2 only: $150 + 0/-10 ^{\circ}\text{C} / \text{I}$ hour, then keep for 24 $\pm \text{I}$ hour at room .	No visual damage		
			temp	ΔC/C		
			2. Initial measure:	NP0: Within $\pm 1\%$ or 1 pF,		
			Spec: refer to initial spec C, D, IR	whichever is greater		
			3. Rapid change of temperature test:	X7R: ±15%		
			NP0/X7R: -55 °C to +125 °C; 300 cycles 15 minutes at lower category temperature; 15 minutes at upper category temperature.	D.F: meet initial specified value IR meet initial specified value		
			4. Recovery time: Class I: 6 to 24 hours			
			Class2: 24 ±2 hours			
			5. Final measure: C, D, IR			
ESD	AEC-Q200	17	Per AEC-Q200-004	A component passes a voltage level if all components stressed at that voltage level pass.		
Solderability	AEC-Q200	18	Preheated to a temperature of 80 °C to 140 °C and maintained for 30 seconds to 60 seconds.	The solder should cover over 95% of the critical area of each termination.		
			Test conditions for lead containing solder alloy	terrimation,		
			Temperature: 235 ±5 °C			
			Dipping time: 2 ±0.2 seconds			
			Depth of immersion: 10 mm			
			Alloy Composition: 60/40 Sn/Pb Number of immersions: I			
			Test conditions for lead-free containing solder alloy			
			Temperature: 245 ±5 °C			
			Dipping time: 3 ±0.3 seconds			
			Depth of immersion: 10 mm Alloy Composition: SAC305			
			Number of immersions: I			



Surface-Mount Ceramic Multilayer Capacitors | Automotive grade | NP0/X7R | 6.3 V to 630 V

TEST	TEST METHOD		PROCEDURE	REQUIREMENTS	
Electrical Characterization	AEC-Q200 19 Parametrically test per lot and sample size requirements, summary to show Min, Max, Mean and Standard deviation at room as well as Min and Max operating temperatures.		ΔC/C Class I: NP0: ±30 ppm/°C		
			Class 1: NP0: -55 °C to +125 °C Normal temperature: 20 °C Class 2: X7R: -55 °C to +125 °C Normal temperature: 20 °C	Class2: X7R: ±15%	
Board Flex	AEC-Q200	21	Part mounted on a 100 mm \times 40 mm FR4 PCB board, which is 1.6 \pm 0.2 mm thick and has a layer-thickness 35 μ m \pm 10 μ m. Part should be mounted using the following soldering reflow profile. Conditions: Class I: Bending 3 mm at a rate of 1 mm/s, radius jig 340 mm Class 2: Bending 2 mm at a rate of 1 mm/s, radius jig 340 mm	No visible damage ΔC/C Class I: NP0: Within ±1% or 0.5 pF, whichever is greater Class 2: X7R: ±10%	

Test Substrate:



	Dimen	sion(m	m)
Туре	а	b	С
0201	0.3	0.9	0.3
0402	0.4	1.5	0.5
0603	1.0	3.0	1.2
0805	1.2	4.0	1.65
1206	2.2	5.0	1.65
1210	2.2	5.0	2.0
1808	3.5	7.0	3.7

Terminal
Strength

AEC-Q200 22 With the component mounted on a PCB obtained with the device to be tested, apply a 17.7N (1.8Kg) force to the side of a device being tested.

This force shall be applied for 60+1 seconds.

Also the force shall be applied gradually as not to apply a shock to the component being tested.

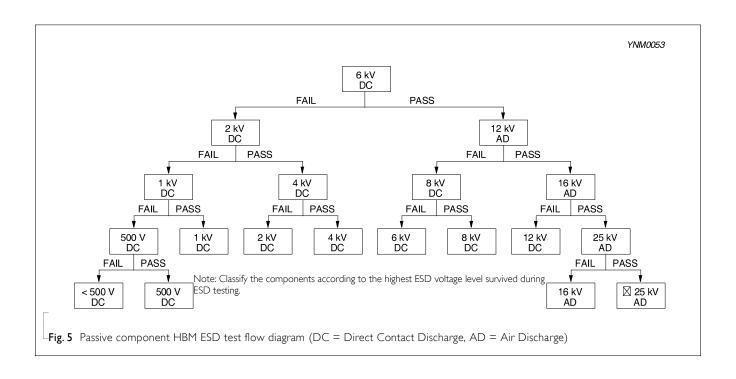
* Apply 2N force for 0402 size.

Magnification of 20X or greater may be employed for inspection of the mechanical integrity of the device body, terminals and body/terminal junction.

Before, during and after the test, the device shall comply with all electrical requirements stated in this specification.



TEST	TEST METHOD		PROCEDURE	REQUIREMENTS
Beam Load Test	AEC-Q200	23	Place the part in the beam load fixture. Apply a force until the	≤ 0805
			part breaks or the minimum acceptable force level required in the user specification(s) is attained.	Thickness > 0.5mm: 20N
				Thickness ≤ 0.5mm: 8N
				≥ 1206
				Thickness ≥1,25 mm: 54N
				Thickness < 1.25 mm: 15N



REVISION HISTORY

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version 8	Nov. 22, 2017	-	- Add X7R/0201/25V/100pF~10nF
Version 7	Jul. 7, 2017	-	- Add X7R/0805/330nF to 470nF/50V, X7R/1206/10uF/6.3V
Version 6	Mar. 31, 2017	-	- Add NPO/0603/InF/50V, X7R/0603/IuF/I0V, X7R/0603/470nF/I6V, X7R/0603/220nF/25V
Version 5	Nov. 15, 2016	-	- Add Soldering Condition
Version 4	Jun. 14, 2016	-	- Add X7R/0805/2.2uF/10V and NPO/1206/1.2nF to 1.5nF/250V
Version 3	Jul. 21, 2015	-	- Tests and Requirements update
Version 2	Jul. 17, 2014	-	- Tests and Requirements update
Version I	Apr. 19, 2013	-	- Capacitance range update
Version 0	Dec. 25, 2012	-	- New

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